

SILICON POWER TRANSISTOR 2SA1010

PNP SILICON EPITAXIAL TRANSISTOR FOR HIGH-VOLTAGE HIGH-SPEED SWITCHING

The 2SA1010 is a mold power transistor developed for high-voltage high-speed switching, and is ideal for use as a driver in devices such as switching regulators, DC/DC converters, and high-frequency power amplifiers.

FEATURES

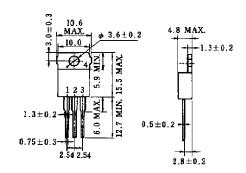
- · Low collector saturation voltage
- · Fast switching speed
- · Complementary transistor: 2SC2334

ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

Parameter	Symbol	Ratings	Unit
Collector to base voltage	VcBO	-100	V
Collector to emitter voltage	VCEO	-100	V
Emitter to base voltage	VEBO	-7.0	V
Collector current (DC)	Ic(DC)	-7.0	Α
Collector current (pulse)	IC(pulse)*	-15	Α
Base current (DC)	I _{B(DC)}	-3.5	Α
Total power dissipation	P _T (Tc = 25 °C)	40	W
Total power dissipation	P⊤ (Ta = 25 °C)	1.5	W
Junction temperature	Tj	150	°C
Storage temperature	T _{stg}	-55 to +150	°C

^{*} PW \leq 300 μ s, duty cycle \leq 10%

PACKAGE DRAWING (UNIT: mm)





Pin Connection

- 1. Base
- 2. Callector
- 3. Emitter
- 4. Fin (Collector)

EIAJ : SC-46 JEDEC : TO-220AB IEC : —

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

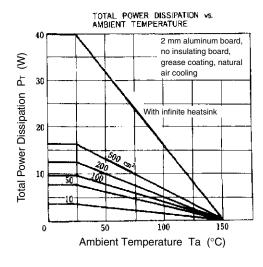
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector to emitter voltage	VCEO(SUS)	Ic = -5.0 A, I _{B1} = -0.5 A, L = 1 mH	-100			٧
Collector to emitter voltage	VCEX(SUS)1	$I_{C} = -5.0 \text{ A}, \ I_{B1} = -I_{B2} = -0.5 \text{ A},$ $V_{BE(OFF)} = 5.0 \text{ V}, \ L = 180 \ \mu\text{H}, \ clamped$	-100			V
Collector to emitter voltage	VCEX(SUS)2	$I_C = -10$ A, $I_{B1} = -1.0$ A, $I_{B2} = -0.5$ A, $V_{BE(OFF)} = 5.0$ V, $L = 180~\mu\text{H}$, clamped	-100			V
Collector cutoff current	Ісво	V _{CB} = -100 V, I _E = 0			-10	μΑ
Collector cutoff current	ICER	$V_{CE} = -100 \text{ V}, \text{ R}_{BE} = 51 \Omega, \text{ Ta} = 125 ^{\circ}\text{C}$			-1.0	mA
Collector cutoff current	ICEX1	$V_{CE} = -100 \text{ V}, V_{BE(OFF)} = 1.5 \text{ V}$			-10	μΑ
Collector cutoff current	ICEX2	$V_{CE} = -100 \text{ V}, V_{BE(OFF)} = 1.5 \text{ V},$ $Ta = 125 ^{\circ}\text{C}$			-1.0	mA
Emitter cutoff current	ІЕВО	V _{EB} = -5.0 V, I _C = 0			-10	μΑ
DC current gain	h _{FE1}	VcE = -5.0 V, Ic = -0.5 A*	40		200	
DC current gain	h _{FE2}	$V_{CE} = -5.0 \text{ V, Ic} = -3.0 \text{ A}^*$	40		200	
DC current gain	h _{FE3}	VcE = -5.0 V, Ic = -5.0 A*	20			
Collector saturation voltage	V _{CE(sat)}	Ic = -5.0 A, I _B = -0.5 A*			-0.6	٧
Base saturation voltage	V _{BE(sat)}	Ic = -5.0 A, I _B = -0.5 A*			-1.5	٧
Turn-on time	ton	$I_{C} = -5.0 \text{ A}, R_{L} = 10 \Omega,$			0.5	μs
Storage time	tstg	$I_{B1} = -I_{B2} = -0.5 \text{ A}, \text{ Vcc } \cong -50 \text{ V}$ Refer to the test circuit.			1.5	μs
Fall time	t _f	nerer to the test circuit.			0.5	μs

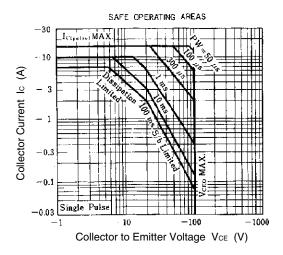
^{*} Pulse test PW \leq 350 μ s, duty cycle \leq 2%

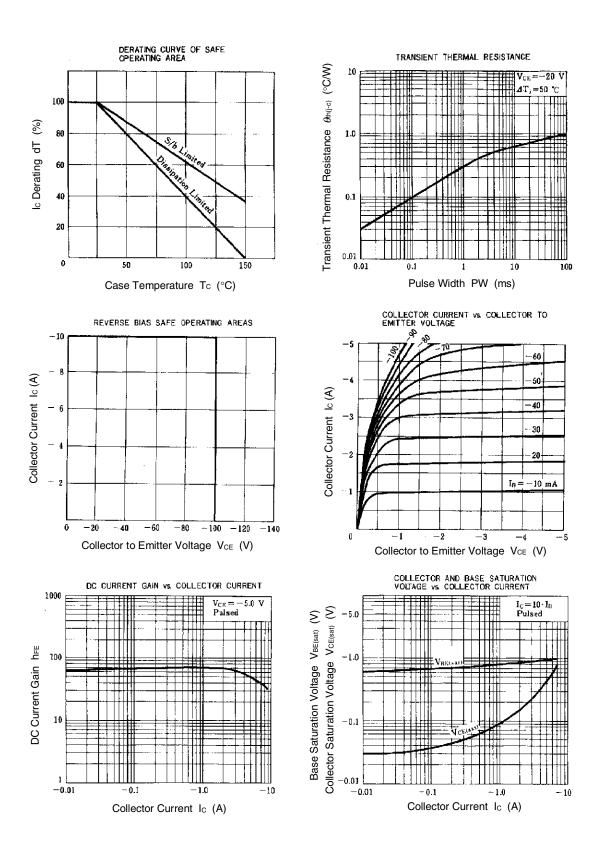
hfe CLASSIFICATION

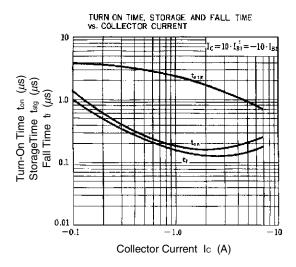
Marking	М	L	K
h _{FE2}	40 to 80	60 to 120	100 to 200

TYPICAL CHARACTERISTICS (Ta = 25°C)

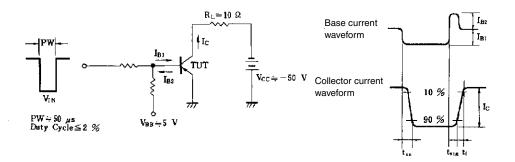








SWITCHING TIME (t_{on}, t_{stg}, t_{f}) TEST CIRCUIT





[MEMO]

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